

Search Notes

Application/Control No.

09/577,932

Examiner

Chris C. Chu

Applicant(s)/Patent under
Reexamination

MARUYAMA ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
451	289 & 388	6/14/2005	C.C.
279	3	6/14/2005	C.C.
118	500 & 730	6/14/2005	C.C.
134	156	6/14/2005	C.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; and IBM_TDB;	6/14/2005	C.C.
Consulted with Daniel Howell 279/3; 118/500 & 730; class 134 & 156	6/6/2005	C.C.
Timothy Eley 451/289 & 388; 279/3	6/6/2005	C.C.